S/N,08/903,453 IN THE UNITED STATES PATENT AND TRADEMARK OFFICE **PATENT**

Applicant: Leonard Forbes et al.

Examiner: George C. Eckert II

Serial No.:

08/903,453

Group Art Unit: 2815

Filed:

July 29, 1997

Docket: 303.378US1

Title:

CARBURIZED SILICON GATE INSULATORS FOR INTEGRATED CIRCUITS

AMENDMENT AND RESPONSE

stant Commissioner for Patents

Washington, D.C. 20231

#17/D 3/3/00 Surler

Applicant has reviewed the Office Action mailed on November 23, 1999. Please amenthe above-identified patent application as follows.

IN THE CLAIMS

Please amend the following claim:

38.(Once Amended) The [memory cell] capacitor of claim 36 wherein:

the first conductive layer comprises polysilicon; and the second conductive layer comprises polysilicon.

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Please add the following new claims:

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39.(New) The integrated circuit field effect transistor of claim 1, further comprising:

an n+-type source region in a p-type silicon substrate;

an n+-type drain region in the substrate;

a channel region in the substrate between the source region and the drain region; and

a gate isolated from the channel region by the gate insulator.

The integrated circuit field effect transistor of claim 1, further comprising: 40.(New)

an n+-type source region in a p-type silicon substrate;

an n+-type drain region in the substrate;

a channel region in the substrate between the source region and the drain region;

a floating gate isolated from the channel region by the gate insulator; and

a polysilicon control gate separated from the Noating gate by a layer of insulating

material.

41.(New) The integrated circuit field effect transistor of claim 2 wherein: 88

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